

Notice of References Cited	Application/Control No. 10/765,837	Applicant(s)/Patent Under Reexamination MATSUMOTO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,871,194	10-1989	Kawashima et al.	285/55
	B	US-6,027,145	02-2000	Tsuru et al.	285/94
	C	US-3,869,393	03-1975	Booker, Aylwin Reed	508/167
	D	US-6,659,509	12-2003	Goto et al.	285/94
	E	US-6,746,057	06-2004	Goto et al.	285/333
	F	US-6,827,996	12-2004	Goto, Kunio	428/36.9
	G	US-6,869,111	03-2005	Goto et al.	285/333
	H	US-6,679,526	01-2004	Yamamoto et al.	285/55
	I	US-2004/0195825	10-2004	Anraku et al.	285/094
	J	US-2003/0066641	04-2003	Yamamoto et al.	166/242.6
	K	US-2003/0160446	08-2003	Goto et al.	285/94
	L	US-2003/0111838	06-2003	Goto et al.	285/94
	M	US-2003/0094810	05-2003	Goto et al.	285/94

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/16516 A1	03-2001	WIPO	Yamamoto et al	F16L 15/04
	O	GB 2140117 A	11-1984	United Kingdom	SHULVER, Roderick Leonard	F16L 15/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0159764	08-2003	Goto, Kunio	148/519
	B	US-4,692,988	09-1987	Shulver et al.	29/458
	C	US-4,256,811	03-1981	Black, Archie L.	428/562
	D	US-6,394,190	05-2002	Linden, Johan	173/1
	E	US-5,678,608	10-1997	Fontana, Giulio	138/96T
	F	US-5,253,902	10-1993	Petelot et al.	285/94
	G	US-4,830,411	05-1989	Tsuru et al.	285/334
	H	US-4,630,849	12-1986	Fukui et al.	285/55
	I	US-4,813,714	03-1989	Fairey et al.	285/94
	J	US-4,527,815	07-1985	Frick, John P.	285/55
	K	US-6,017,857	01-2000	Heimann et al.	508/136
	L	US-4,758,025	07-1988	Frick, John P.	285/55
	M	US-4,474,651	10-1984	Yauchi et al.	285/329

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,468,309	08-1984	White, Gerald W.	427/528
	B	US-3,996,398	12-1976	Manfredi, Pierre	427/451
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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